

Notice of References Cited	Application/Control No. 10/650,592	Applicant(s)/Patent Under Reexamination AFEYAN ET AL.	
	Examiner Mohammad Meah	Art Unit 1652	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0068792	04-2003	Chen et al.	435/183
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*	N	WO 0064485	01-2000	epo	Davis et al.	
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	T					

NON-PATENT DOCUMENTS

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*	U	Holvoet et al. JBC 1991, vol. 266, pp 19717-10724
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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